Probing the Variation of the Intervalley Tunnel Coupling in a Silicon Triple Quantum Dot

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Electrons confined in silicon quantum dots exhibit orbital, spin, and valley degrees of freedom. The valley degree of freedom originates from the bulk band structure of silicon, which has six degenerate electronic minima. The degeneracy can be lifted in silicon quantum wells due to strain and electronic confinement, but the "valley splitting" of the two lowest-lying valleys is known to be sensitive to atomic scale disorder. Large valley splittings are desirable to have a well-defined spin qubit. In addition, an understanding of the intervalley tunnel coupling that couples different valleys in adjacent quantum dots is extremely important, as the resulting gaps in the energy-level diagram may affect the fidelity of charge-and spin-transfer protocols in silicon quantum-dot arrays. Here we use microwave spectroscopy to probe variations in the valley splitting, and the intra- and intervalley tunnel couplings (t_{ij} and t_{ij}) that couple dots *i* and *j* in a triple quantum dot. We uncover large variations in the ratio of intervalley to intravalley tunnel couplings $t_{12}/t_{12} = 0.90$ and $t_{23}/t_{23} = 0.56$. By tuning the interdot tunnel barrier we also show that t_{ij} scales linearly with t_{ij} , as expected from theory. The results indicate strong interactions between different valley states on neighboring dots, which we attribute to local inhomogeneities in the silicon quantum well.

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I. INTRODUCTION

Continuous research on electron spin qubits defined in silicon quantum dots has led to increasingly impressive levels of quantum control, with recent demonstrations of high single-qubit fidelities [1-3] and > 90% two-qubit gate fidelities [4,5]. Progress has been fueled by an investment in high-quality Si/Si_{0.7}Ge_{0.3} heterostructures [6,7], coupled with the advent of accumulation-mode device designs that are less sensitive to disorder and enable fine control over quantum-dot electrons [8-11]. For example, through time-domain control of the quantum-dot confinement potential, it is now feasible to shuttle a single charge down an array of nine silicon quantum dots in approximately 50 ns [12].

Control of valley states in Si quantum devices, especially those based on Si/Si_{0.7}Ge_{0.3} heterostructures, is an outstanding challenge [13–15]. While spin-1/2 electrons are often viewed as a canonical two-level system, the valley degree of freedom in the electronic band structure of silicon can give rise to low-lying valley-orbit states [16–18]. For single quantum dots, low-lying valley states inhibit spin initialization and readout routines that are based on energy-dependent tunneling [19]. Moreover, spin-valley mixing leads to spin-relaxation hotspots when the Zeeman splitting of the single-electron spin state is comparable to the valley splitting [20–23].

Complications associated with valley splitting are exacerbated in silicon quantum-dot arrays. The lifting of the \pm z-valley degeneracy that gives rise to valley splitting is set by the abruptness of the electronic interfaces that break inversion symmetry [24]. Spatial inhomogeneities in the structure of the quantum well therefore lead to dot-to-dot variations in the valley splitting [25–27]. In Si/Si_{0.7}Ge_{0.3} systems the valley splitting often lies between 25–300 μ eV [22,28–33]. Due to tighter confinement in the z direction, valley splittings >200 μ eV have been observed in Si-MOS systems [34–36].

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The magnitude of the valley splitting is generally sufficient to understand the consequences on individual spins in isolated quantum dots. However, the intravalley t_{ij} and intervalley t ii tunnel couplings, which depend on the socalled valley-orbit phase, will influence the energy-level structure of a linear array of tunnel-coupled quantum dots. In particular, the location of anticrossings in the energylevel diagram will be set by the valley splitting of each dot $E_{VS,i}$, and the magnitude of the avoided crossings in the energy-level diagram will be set by t_{ij} and t_{ij} [37– transitions, Landau-Žener-40]. Nonadiabatic Stuckelberg-Majorana interference, and leakage into higher-lying energy levels may all influence the fidelity of spin-transfer protocols [41-43]. Moreover, the specific configuration of valley states can strongly affect multielectron exchange coupling in the quantum-dot device [44].

Here we investigate valley splitting and intervalley tunnel coupling using microwave spectroscopy. A triple quantum dot (TQD) is embedded in a superconducting cavity in the circuit quantum electrodynamics device architecture (cQED) [45]. The dipole moment of an electron confined in a quantum dot couples to the electromagnetic field of the superconducting cavity [46–50]. By probing the microwave transmission through the cavity we sensitively map out the energy-level structure of the TQD. To take a first step towards measuring the spatial dependence of valley parameters, we extract the valley splitting of each dot and the intra- and intervalley tunnel couplings in the TQD. We find significant variations in the quantumdot valley parameters across the approximately 200-nm length scale of the device. Valley splittings range from 38–63 μ eV and the intervalley tunnel coupling t_{12} between

dots 1 and 2 is nearly 2 times larger than t_{23} . These results have important implications on future experiments aimed at demonstrating coherent spin shuttling in quantum-dot arrays and reinforce the need for additional improvements in the growth of Si/Si_{0.7}Ge_{0.3} heterostructures, especially

interface abruptness.

Beyond providing fundamental insight into the nature of the valley degree of freedom in Si/Si_{0.7}Ge_{0.3} quantum devices, our results pave the way for coherent coupling of resonant-exchange (RX) spin qubits to microwavefrequency photons. Coherent coupling of a single spin to a single photon has been achieved in silicon double quantum dots (DQDs) using a combination of electric dipole coupling and spin-orbit coupling generated by the fringing field of a micromagnet [51–53]. With RX qubits, the electric field of a cavity photon couples to spin through the exchange interaction. High-fidelity gate operations have been demonstrated with electrically tunable RX spin qubits, which can operate at zero magnetic field. This increases compatibility with superconducting cavities [3] and allows for scalable control of the qubit frequency. Strong coupling of a RX spin qubit to a photon has recently

been demonstrated in a GaAs TQD [54]. However, due to isotopic enrichment, silicon spin qubits offer much longer spin coherence times and may enable operation deep in the strong coupling regime, once the complications stemming from the presence of valley states are overcome.

II. VALLEY STATES IN SILICON

The band structure of bulk silicon has six degenerate conduction-band minima that are located close to the boundary of the first Brillouin zone, as depicted in Fig. 1(a) [13,55]. Due to the slight difference in lattice constant of the Si quantum well and the surrounding Si_{0.7}Ge_{0.3} buffer layers, the Si quantum well is under tensile strain, which increases the energy of the $\pm x, y$ valleys relative to the $\pm z$ valleys [6]. Sharp quantum-well interfaces break inversion symmetry and couple the two $\pm z$ valleys, resulting in valley splitting [13].

Specifically, the Hamiltonian of the subsystem consisting of the $\pm z$ valleys on dot *i* can be written in the $\{|i, +z*, |i, -z*\}$ basis as

$$H_{V,i} = \begin{pmatrix} 0 & \varPhi_i \\ \varPhi_i^* & \end{pmatrix}, \tag{1}$$

with complex valley coupling matrix element $\mathbf{P}_i = |\mathbf{P}_i|e^{-i\varphi_i}$ [25,42]. The eigenstates of this system are

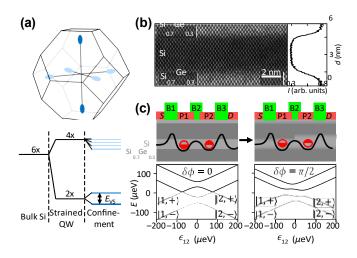


FIG. 1. Valley physics in silicon. (a) First Brillouin zone of silicon, with six degenerate conduction-band minima. Tensile strain in the Si quantum well separates the $\pm z$ valleys from the x, y valleys, while vertical confinement lifts the degeneracy of the \pm valleys. (b) TEM image of the Si/Si_{0.7}Ge_{0.3} quantum well. (c) Schematic cross section of a DQD with corresponding energy levels. An ideal Si/Si_{0.7}Ge_{0.3} quantum well with abrupt interfaces (left) leads to large and uniform valley splittings, and no intervalley tunnel coupling, while a realistic quantum well with soft interfaces and step edges (right) will have small, nonuniform valley splittings, and strong intervalley tunnel coupling between the quantum dots. Corresponding energy-level diagrams are shown in the bottom graphs.

 $|i, \pm * = (1/2)^{\vee}|i, +z*\pm e^{i\varphi_i}|i, -z*$, with eigenenergies $E_{\pm} = \pm |\varphi_i|$. Consequently, the valley splitting of dot *i* is $E_{\text{VS},i} = E_{\pm} - E_{\pm} - 2 \varphi_i$ and φ_i is the valley-orbit phase. The magnitude and phase of φ_i are physically rooted in the local properties of the quantum well [25,42]. For example, spatial variations in interface abruptness and disorder will cause φ_i to be a function of position in the plane of the quantum well, $\varphi_i = \varphi_i(x, y)$, hence the term "valley-orbit coupling."

While the valley-orbit phase does not immediately affect the energy levels of a single quantum dot, its consequences are evident when considering a system of two tunnel coupled quantum dots (dots *i* and *j*). In the basis $\{|i, +z*, |i, -z*, |j, +z*, |j, -z*\}$, the Hamiltonian can be expressed as

$$H_{ij}(E_{ij}) = \begin{pmatrix} \frac{E_{ij}}{\langle \bullet \rangle} & \langle \bullet \rangle & t_c & 0 \\ & \frac{E_{ij}}{2} & 0 & t_c \\ & t_c & 0 & \frac{E_{ij}}{2} & \langle \bullet \rangle \\ & 0 & t_c & \langle \bullet \rangle_i^* & -\frac{E_{ij}}{2} \end{pmatrix}, \quad (2)$$

with tunnel coupling t_c between identical z-valleys of dots i and j. We neglect the coupling of opposing z valleys between the quantum dots, as it is a higher-order coupling contribution [25]. The energy-level detuning between dots i and j is defined by E_{ij} μ_i μ_j with corresponding decoupled chemical potentials $\mu_{i(j)}$.

We diagonalize the local single-dot valley dynamics of dots *i* and *j* by transforming into the basis $\{|i_{i+*}, |i_{i-*}, |j_{i+*}, |j_{i-*}\}, \text{ where } \pm \text{ refers to the bond$ $ing and antibonding valley state combinations.} We$ obtain

$$H_{ij}(E_{ij}) = \begin{vmatrix} 2 & & & & & & & \\ 2 & & & & & & & \\ 0 & \frac{E_{ij}}{2} & & t_{ij} & & t_{ij} \\ & & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & & & \\ & & & & & \\ & & & & & \\ & & & & & &$$

with intra- and intervalley tunnel coupling $t_{ij} = (1/2)t_c(1 e^{-i\delta\varphi_{ij}})$ and $t_{ij} = (1/2)t_c(1 e^{-i\delta\varphi_{ij}})$, and valley phase difference $\delta\varphi_{ij} = \varphi_i \quad \varphi_j$ [42,56]. This Hamiltonian results in four energy bands with two intravalley and two intervalley anticrossings determined by t_{ij} and t_{ij} , respectively.

In practice, the valley splitting and phase are strongly dependent on the valley coupling dynamics at the Si/Si_{0.7}Ge_{0.3} quantum-well interfaces. Figure 1(b) shows a high-resolution TEM image of the heterostructure. The varying Ge content causes an intensity contrast between the different layers of the heterostructure. To the right, we plot the average of the grayscale pixel intensity for each row of the image. The interface is of fairly high quality. This is expressed by the smooth transition between

the average intensities for Si and Si_{0.7}Ge_{0.3} only spanning a few (<5) lattice sites over the displayed range. However, even a small number of atomic steps in the interface can have a large impact on the valley phase difference and overall structure of the DQD energy-level diagram [16,24,37,39]. A uniform (step-edge-free) interface in the region of the DQD corresponds to the limit $\delta \varphi_{ii}$ = 0, which results in a set of bonding-antibonding charge states for each of the valleys [see Fig. 1(c), left panel]. Realistic quantum wells will have less abrupt interfaces and step edges that result in intervalley tunnel coupling [see Fig. 1(c), right panel]. For example, with $\delta \varphi_{ii} = \pi/2$, there are four avoided crossings in the energy-level diagram, indicating the presence of both valley-conserving and nonconserving charge transitions between dots *i* and *j*. Moreover, smooth, disordered interfaces will generally yield smaller $E_{\rm VS}$ that exhibit dot-to-dot variations [25]. Comprehensive studies of the full set of valley parameters have so far not been conducted. Microwave spectroscopy of a TQD in the cQED architecture provides an opportunity to sensitively probe the spatial variation of valley states in a silicon quantum device.

III. EXPERIMENTAL SETUP

In this experiment a half-wavelength $\lambda/2$ superconducting cavity with resonance frequency $f_{c} = 6.76$ GHz and photon loss rate $\kappa/2\pi = 1.4$ MHz is coupled to two Si/Si_{0.7}Ge_{0.3} TQDs [Fig. 2(a)]. The TQDs are fabricated using an overlapping gate architecture [29]. The center pin of the cavity is galvanically connected to the cavity-coupler gate "CP," as shown schematically in Fig. 2(b). Along with screening gates S1 and S2, the CP gate is part of the first of three overlapping Al gate layers [57]. Plunger (barrier) gates are defined in the second (third) aluminum layers and the layers are electrically isolated from one another by a native Al₂O₃ oxide barrier.

The TQD chemical potentials are controlled with plunger gates P1–P3, while the interdot barriers and barriers to the source (S) and drain (D) reservoirs are controlled by gates B1–B4. To enhance the dot-cavity coupling, the CP gate is designed to wrap around dot 3, which effectively adds a potential barrier between dot 3 and the D reservoir, in addition to the barrier defined by gate B4. A SEM image of the TQD is shown in Fig. 2(c), with a white dashed line indicating the long axis of the TQD. Details related to the fabrication of similar devices have been presented elsewhere [58]. The data sets in this paper are acquired from the TQD located at the right antinode of the cavity (denoted RTQD).

We map out the TQD charge stability diagram [Fig. 2(d)] by measuring the normalized cavity transmission A/A_0 as a function of the gate voltages V_{P1} and V_{P3} [46]. When sweeping V_{P1} and V_{P3} we observe nearly horizontal charge transitions in the cavity response that

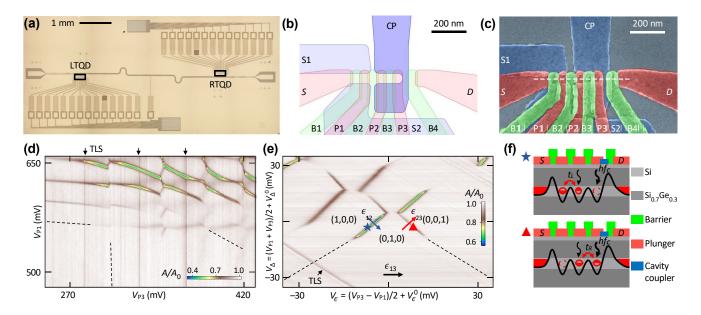


FIG. 2. Cavity-coupled TQD. (a) Optical image of a superconducting cavity coupled to two TQDs. (b) Schematic of the TQD device with cavity coupler gate (CP). (c) False-color SEM image of the TQD. (d) Large-scale charge stability diagram of the TQD. The dashed black lines indicate the three quantum-dot charge transitions. Features corresponding to two-level systems (TLSs) are indicated by black arrows. (e) Charge stability diagram in the single-electron regime. The blue star indicates the (1,0,0)-(0,1,0) interdot transition and the red triangle indicates the (0,1,0)-(0,0,1) interdot transition. (f) Schematic of the operating points indicated by the symbols in (e). Due to the geometry of CP, the microwave coupling to dot 3 is strongest, as indicated by the thickness of the black arrows.

correspond to charge transfer between dot 1 and the *S* reservoir. As a result of the mutual charging energy, the dot-1 charge transitions shift abruptly when an electron is added or removed from dot 3 (see vertical dashed line). As the CP gate limits the tunneling rate to the *D* reservoir in the few-electron regime, no direct cavity response is observed for dot-3 charge transitions. The absence of dot-1 transition shifts for V_{P3} below the indicated vertical dashed line however allows us to verify the single-electron occupation of dot 3. Due to cross-coupling of the gate voltages V_{P1} and V_{P3} to dot 2, we observe angled dot-2 charge transitions in the data, which interact with the dot-1 and dot-3 charging transitions.

For the remainder of the paper, we operate in the single-electron regime. By performing pairwise sweeps of V_{P1}/V_{P2} and V_{P2}/V_{P3} , we tune the device towards the (1,0,0)-(0,1,0)-(0,0,1) transition shown in Fig. 2(e) (see Appendix A). Here we use the virtual gates $V_E = (V_{P3} - V_{P3})$ $V_{P1}/2 + V^0$ and $V_{\phi} = (V_{P1} + V_{P3})/2 + V^0$ to access the different charge states of the TQD. Voltage offsets V_{R} and V_{\bullet}^{0} are used to move the (0,1,0) charge state to the origin. In this tuning configuration, the tunneling rates to the S and D reservoirs are suppressed relative to f_c , and the primary cavity response stems from the (1,0,0)-(0,1,0) and (0,1,0)-(0,0,1) interdot charge transitions. We denote these transitions with a blue star and a red triangle, respectively, and show a schematic of the device cross section in Fig. 2(f). The cross section corresponds to the device area indicated by the white dashed line in Fig. 2(c). The

asymmetric geometry of the CP gate creates an electric field gradient across all three dots, allowing us to observe a signal at both interdot charge transitions.

IV. CAVITY RESPONSE TO VALLEY STATES

To gather insight into the TQD valley physics we sketch the low-lying TQD energy levels as a function of the detuning E_{13} between dots 1 and 3 in Fig. 3(a). In this regime the (1,0,0)-(0,1,0) and (0,1,0)-(0,0,1) interdot charge transitions can be analyzed independently. Each interdot transition involves four energy levels. Focusing on the (1,0,0)-(0,1,0) transition the four relevant levels are 1, +and 2, +*

The microwave cavity is sensitive to charge dynamics within the TQD due to dipole coupling between the electron trapped in the device and the cavity electric field [46,47]. In general, the cavity response A/A_0 is strongest near charge avoided crossings in the energy-level diagram [see blue, red, and green arrows in Fig. 3(a)]. At low temperatures where $k_BT_e \mp E_{VS,i}$, with Boltzmann constant k_B and electron temperature T_e , the electron primarily resides in the ground state and the excited valley states are not prominent in the cavity response. Participation of the excited valley states [1, +*2, +*3]in the cavity response can be increased by raising the temperature and thermally exciting the charge according to the Boltzmann distribution with occupation probability $p_i = e^{-E_i/k_B T_e} / e^{-E_i/k_B T_e}$, with state energy E_i [30,56]. Increasing the electron temperature, such that

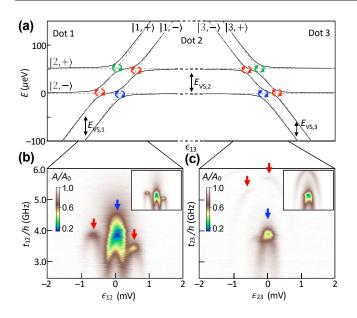


FIG. 3. Cavity response in the single-electron regime at $T_e = 350$ mK. (a) Energy bands of the TQD, with valley splittings denoted by $E_{VS,i}$. At low temperatures, only the transition between the lowest energy states (blue) is visible in the cavity response. By increasing temperature, intervalley transitions (red) can be accessed. (b) Cavity response A/A_0 near the (1,0,0)-(0,1,0) transition as a function of t_{12} and the detuning E_{12} between dots 1 and 2. The colored arrows correspond to the transitions highlighted in (a). (c) A/A_0 in the vicinity of the (0,1,0)-(0,0,1) transition as a function of t_{23} and E_{23} . Insets in (b),(c) show the simulated cavity response.

 $k_BT_e \not \not E_{VS,i}$, is effective at increasing the visibility of the higher-lying intervalley transitions in the cavity response (red transitions). In practice, the excited intravalley transitions (green transitions) are still masked by the larger participation of the ground-state intravalley transitions at nearly the same voltage and are therefore not visible here. Nevertheless, the cavity-response data are sufficient to extract the valley splittings, and intra- and intervalley tunnel couplings.

Figure 3(b) displays the cavity transmission A/A_0 as a function of the interdot detuning E_{12} and tunnel coupling t_{12} with T_e 350 mK, which is achieved by actively heating the mixing chamber plate of the dilution refrigerator (see Appendix B). Here the detuning is plotted in units of mV, as the lever arm varies slightly as a function of t_{12} . The ground-state transition $1 \downarrow -* \leftrightarrow |2$, corresponds to the center arch that is most pronounced in the data. With $E_{12\approx}0$, the cavity response is the strongest around $t_{12}/h \neq H$ GHz (h is Planck's constant), where the energy difference of the coupled states is most insensitive to noise on the detuning axis E_{12} and the transition energy is resonant with the cavity $E_2 - E_1 = hf_c$. In contrast to the valley-free case [50,57], here $E_2 - E_1 < 2t_{12}$, as level

repulsion from the excited valley states 1_{\downarrow} +* and $2_{,+*}$ reduce its effective energy splitting.

Next to the strong central feature we observe two similar, but fainter, arches. These arches correspond to the thermally occupied intervalley transitions $1, \pm * \leftrightarrow 2$, (red arrows). We note that tuning t_{12} by-adjusting V_{B2} affects both the inter- and intravalley signatures in the data. Moreover, the position of the side arches can be qualitatively understood by looking at the energy diagram in Fig. 3(a). Raising $E_{VS,1}$ will move the $|1,+* \leftrightarrow |2,$ transition towards more negative detuning. Similarly, $E_{VS,2}$ affects the horizontal positioning of the right-side arch via transition. From this qualia shift of the 1, $-* \leftrightarrow |2,$ tative analysis and the larger spacing between the left and center feature, we deduce $E_{VS,1} > E_{VS,2}$. To understand the vertical positioning of the arches, we focus on the strongest cavity signal at the maxima of the arches indicated by the blue (red) arrows. At these points the intra(inter)valley transition energies are dominated by the contribution of the corresponding couplings $t_{12}(t_{12})$ and coincide with hf_c . The observation that these points are reached at different values of t_{12} for the two side arches indicates that in fact t_{12} changes with detuning in our system, i.e., t = t (E). This suggests that also $t_1 = t_1$ (E) due to their functional interdependence. Specifically, with $t_{12}(E_{\pm} 0)/h = 3.5$ GHz, t is large enough for the $1, | -* \leftrightarrow |^2$, transition to be resonant at positive detuning, while it is too small at negative detuning leaving the $|1, +* \leftrightarrow |2$, transition below resonance. Unless the detuning dependence is explicitly specified, we identify $t_{ij} = t_{ij}$ (E = 0) and $t_{ij} = t_{ij}$ (E = 0). We assume that this detuning dependence is caused by cross capacitance between the plunger gates and the tunnel barrier potential.

For the (0,1,0)-(0,0,1) transition [Fig. 3(c)], we observe similar behavior for the $2, -* \leftrightarrow |3|$, intravalley transition. However, the $2, \pm * \leftrightarrow |3|$, intervalley features do not appear in the shape of two arches next to the main feature, but they merge into one bigger arch at much higher t_{23} . The qualitative differences between the datasets indicates a variation of the valley parameters across the TQD. The asymmetries caused by the variation of t and t can be reproduced by input-output simulations shown in the insets of Figs. 3(b) and 3(c) [59].

V. QUANTITATIVE EXTRACTION OF THE VALLEY PARAMETERS

We now quantitatively analyze the cavity response data in light of the theoretical background given in Sec. II. The energy levels in the vicinity of the (1,0,0)-(0,1,0) transition are plotted in Fig. 4(a). The dashed lines indicate the expected energy levels with no tunnel coupling, while the solid lines show the energy levels with $|t_{12}|/h = 2.9$ GHz and $|t_{12}|/h = 2.6$ GHz. We denote the intravalley transition $|1, -* \leftrightarrow |2, -*$ as (i), and the intervalley transitions

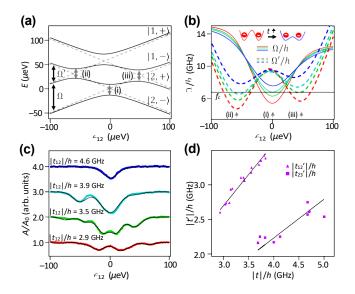


FIG. 4. Quantitative analysis of the cavity response. (a) Energy-level diagram for $|t_{12}|/h = 2.9$ GHz. Transitions Q and Q are energetically accessible at $T_e = 350$ mK. (b) Transition frequencies Q/h and Q/h as a function of E_{12} for the four values of t_{12} indicated in (c). The minima in the transition frequencies are labeled (i)–(iii). (c) Line cuts extracted from Fig. 3(b) for different |t| (fits are shown in black). The line cuts correspond to the low |t| regime, resonant regimes for both intra- and intervalley transitions, and the high |t| regime. (d) Extracted intervalley tunnel coupling rates $|t_{ij}|/h$ as a function of $|t_{ij}|/h$ for both interdot transitions.

 $|1, \pm * \leftrightarrow |2$, as (ii) and (iii), respectively. We plot the intra- and intervalley transition frequencies Q/h and Q/h as a function of E_{12} in Fig. 4(b), and the cavity frequency f_c is shown for comparison. An appreciable cavity response is observed near detunings E_{12} where Q/h or $Q/h_{\approx} f_c$. Q/h exhibit a single minimum corresponding to the ground-state intravalley transition (i) close to $E_{\pm}0$. Similarly, the two intervalley transitions (ii) and (iii) lead to two minima in Q/h at finite detuning.

We next utilize Figs. 4(a) and 4(b) to identify the features in the cavity-response data. Four linecuts extracted from Fig. 3(b) data set are plotted in Fig. 4(c), and show the evolution of A/A_0 as a function of E_{12} as t_{12} is reduced. Qualitatively, the complexity of the cavity response increases as t_{12}/h is reduced from 4.6 to 2.9 GHz. At $|t_{12}|/h = 4.6$ GHz, both transition energies lie above resonance for the whole range of E_{12} , with Q/honly approaching f_c at $E_{12}=0$. At this point, the intervalley features are very weak and only the intravalley transition (i) contributes to an appreciable dispersive signal in the cavity transmission. At $|t_{12}|/h| = 3.9$ GHz, both (i) and (ii) are nearly resonant with the cavity, leading to a strong suppression of A/A_0 at E_{12} , and a local minimum at negative E_{12} . Reducing the tunnel coupling further to $|t_{12}|/h = 3.5$ GHz, (iii) is nearly resonant with

 f_c , causing a pronounced reduction of the cavity transmission at positive detuning. As (i) is below resonance, we observe two additional minima in A/A_0 , corresponding to the two detuning values where $Q/h = f_c$. Finally, when $t_{12}/h = 2.9$ GHz, the ground-state intravalley transition (i) and both intervalley transitions (ii) and (iii) lie below resonance, so that there are in theory six detuning values at which either Q/h or $Q/h = f_c$. However, the central four resonance conditions lie pairwise close to each other, such that their corresponding features merge into two central transmission minima [see lower portion of Figs. 3(b), and 4(c)].

To determine the TOD valley parameters we quantitatively analyze linecuts similar to those shown in Fig. 4(c). Superimposed on the data are best fits obtained by numerically diagonalizing the Hamiltonian in Eq. (3) for each value of E_{12} and feeding the resulting energies into cavity input-output theory, where the cavity signal is calculated based on the coherent coupling of the cavity to the delocalized electron and the decoherence of the coupled systems [60]. To generate the level diagram, we treat $t_{12} = |t_{12}|$ and $t_{12} = |t_{12}|$ as real valued parameters for the fits, which leaves the energy levels unaffected [42,56]. To account for the observed asymmetry in Fig. 3(b) intervalley tunnel couplings at positive and negative detuning, we parameterize a small linear dependence of the intravalley coupling on detuning $t_{ij}(E_{ij}) = t_{ij}(E_{ij} = 0)$ $a_{ij}E_{ij}$. Fit parameters of the Hamiltonian are $E_{VS,i}$, t_{ij} ($E_{ij=0}$), a_{ij} , leverarm α_{ij} and the valley phase difference $\delta \varphi_{ij}$, which is defined by $|t_{ij}/t_{ij}| = \tan(\delta \varphi_{ij}/2)$. We take into account the finite population of the excited states at $T_e = 350$ mK via the Boltzmann distribution. In addition, we fit the charge-cavity coupling rate $g_{ii}/2\pi$. The inhomogenous broadening of the features caused by charge noise is implemented by a Gaussian convolution of standard deviation σ_{ii} . Combining the results from the linecut fits we find $g_{12}/2\pi = 37$ MHz and $\sigma_{12} = 9 \ \mu eV$. The charge decoherence rate $\gamma_{12}/2\pi$ 32 MHz is extracted in a separate measurement by probing the ESR linewidth. Similar data (not shown) are acquired near the (0,1,0)-(0,0,1) transition, with best-fit parameters $g_{23}/2\pi = 23$ MHz, $\gamma_{23}/2\pi = 39$ MHz, and σ_{23} 7 μeV.

We first extract the valley splitting of each quantum dot. Analyzing the linecuts yields $E_{VS,1} = 63 \ \mu eV$ and $E_{VS,2}$ 53 μeV , whereas the data from the (0,1,0)-(0,0,1) transition yields $E_{VS,2} = 50 \ \mu eV$ and $E_{VS,3} = 38 \ \mu eV$. The magnitude of the valley splitting is consistent with previous measurements on similar devices [30]. Crucially, the values of $E_{VS,2}$ obtained from the two independent measurements are self-consistent and imply that the valley splittings are insensitive to small variations in the plunger gate voltages.

Next, we extract values of $|t_{12}|$ for multiple values of $|t_{12}|$, as shown in Fig. 4(d). We expect a linear relationship between $|t_{ij}|$ and $|t_{ij}|$ described by the formula $|t_{ij}/t_{ij}| = \tan(\delta \varphi_{ij}/2)$. We determine the scaling relation

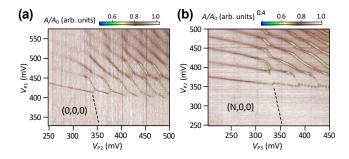


FIG. 5. Single-electron occupation of the TQD. (a) Cavity transmission A/A_0 as a function of plunger gate voltages V_{P1} and V_{P2} , showing charge stability diagram of dots 1 and 2 with dot 3 empty. (b) A/A_0 as a function of V_{P2} and V_{P3} , showing charge stability diagram of dots 2 and 3 with dot 1 accumulated to extend the reservoir.

to be $|t_{12}/t_{12}| = 0.90$ for the (1,0,0)-(0,1,0) transition with $a_{12} = 0.02$. Similarly, we extract $|t_{23}/t_{23}| = 0.56$ for the (0,1,0)-(0,0,1) transition with $a_{23}=0$. Using these scaling relationships, we find valley phase differences $\delta \varphi_{12} = 84^{\circ}$ and $\delta \varphi_{23} = 58^{\circ}$. The substantial valley phase differences point toward a level diagram closely resembling that shown in Fig. 4(a), with the intra- and intervalley tunnel couplings leading to four avoided crossings. In contrast, an abrupt and uniform Si/Si_{0.7}Ge_{0.3} interface would yield $\delta \varphi_{12}=0$, with only nonzero intravalley couplings [left panel of Fig. 1(c)].

VI. CONCLUSION AND OUTLOOK

In conclusion, we use microwave spectroscopy to probe the energy-level structure of a Si TQD containing a single electron. Consistent with previous work, we find significant variations in the valley splitting across the device [22,28–32]. Going beyond previous work, we capitalize on the sensitivity of cQED microwave spectroscopy to the curvature of the quantum-dot energy levels to probe variations in the intervalley tunnel coupling. Consistent with theory, we find that the intervalley coupling scales linearly with the intravalley coupling. Moreover, examination of both the (1,0,0)-(0,1,0) and (0,1,0)-(0,0,1) interdot charge transitions allows us to probe variations in the valley-orbit phase. Significant variations in the valley phase difference $\delta \varphi_{ii}$ over the small approximately 200 nm length scale of the device highlights the importance of improving the Si/Si_{0.7}Ge_{0.3} interface quality. We expect that experimental characterizations similar to those performed here may be achieved with reflectometry setups utilizing external resonant circuits [60].

Our results indicate a significant variation of the valley splitting and valley-orbit phase across the TQD. Variable valley splittings can impact single-qubit operation and readout, as rapid spin-valley mixing occurs when the Zeeman energy and valley splitting are comparable, resulting in vastly reduced spin liftetimes [34]. Small valley splittings also limit the use of Pauli spin blockade for singlet-triplet readout in silicon [61]. With larger valley splitting, a device as studied here will also allow the coupling of a resonant exchange-based encoded spin qubit to a superconducting cavity, opening the door to scalable spin-photon links.

Considering efforts to transport spins down large quantum-dot arrays [12], spatial variations in the valley phase difference $\delta \varphi_{ij}$ could be especially problematic. From the Landau-Zener model, the nonadiabatic transition probability at an avoided crossing is exponentially dependent on the square of the coupling matrix element. Ideally, the intervalley gaps in the level diagram would be zero or small, limiting mixing into excited valley states during spin shuttling. The nonzero valley phase difference, and its variation across the device, could very well impact the performance of spin-shuttling protocols. Looking forward, the measurements presented here can be used to provide valuable feedback on the quality of interfaces in the Si/Si_{0.7}Ge_{0.3} system.

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APPENDIX A: CHARGE STABILITY DIAGRAMS

In this appendix we show additional data exemplifying the pairwise sweeps used to achieve the single-electron regime in the TQD. As the dot 3 to drain transition is opaque, we operate using the dot 1 to source transition and the capacitive interdot interactions to determine the charge occupation in the array. In Fig. 5(a) we show the charge stability diagram of dots 1 and 2 while keeping dot 3 empty. We increase V_{B1} to allow for fast tunneling between the source lead and dot 1. The first dot-1 electron transition is clearly visible, with the higher transition becoming smoother as the tunneling rate increases. From the absence of capacitive jumps in the dot-1 transition, we can infer the last electron transition of dot 2, indicated with the vertical black dashed line.

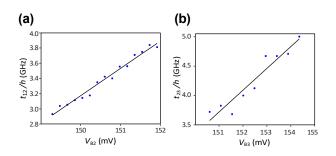


FIG. 6. Tunnel coupling calibration in the TQD. (a) t_{12} is extracted as a function of V_{B2} by fitting the input-output model described in the main text to line cuts of Fig. 3(b) data. (b) Similarly, t_{23} is extracted as a function of V_{B3} using line cuts of Fig. 3(c) data.

To access the single-electron regime for dots 2 and 3, we accumulate dot 1 such that we can now see the extended source to dot-2 transition in Fig. 5(b). This allows us to directly find the last electron in dot 2 and again infer the last dot 3 transition by the missing capacitive shifts in the dot-2 transition for lower V_{P3} . Here, the vertical black dashed line indicates the last electron transition for dot 3. Combining the information gathered from these pairwise sweeps, we tune the TQD into the single-electron regime.

APPENDIX B: CALIBRATING THE INTERDOT TUNNEL COUPLING

We show the calibration of the intravalley tunnel couplings used in Figs. 3(b) and 3(c) in this appendix. The data for these figures are taken by stepping the barrier gate voltages $V_{B2}(V_{B3})$ (vertical axis) and sweeping the detuning (horizontal axis). We then fit our input-output model for different values of the barrier gate voltages and extract the tunnel coupling for each line cut. The extracted tunnel couplings can be well fit by a linear dependence (see Fig. 6) allowing us to continuously convert the vertical axis from units of barrier gate voltage to tunnel coupling.

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